

**Notice of References Cited**

Application/Control No.

10/089,178

Applicant(s)/Patent Under  
Reexamination  
HIBINO ET AL.

Examiner

Devona E. Faulk

Art Unit

2615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,661,811	08-1997	Huermann et al.	381/309
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2246688 A	02-1992	United Kingdom	SMITH et al.	H04B 1/10
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Applicant's admitted prior art, page 1, one 13-page 3.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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